


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599208	<b>Applicant(s)/Patent Under Reexamination</b>  DELAHAYE, FRANCK
	<b>Examiner</b>  Kin-Chan Chen	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
438	745, 747, 750, 753,	2/24/2009	KCC
216	83, 84	2/24/2009	KCC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST KEY WORD SEARCH, USPAT, USPG_PUB, EPO, JPO, DERWENT, IBM_TBD, INVENTOR SEARCH	2/24/2009	KCC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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